# SiPM: Development and Applications

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# SiPM characteristics: general



- Matrix of independent pixels arranged on a common subtrate
- Each pixel operates in a selfquenching Geiger mode
- Each pixel produces a standard response independent on number of incident photons (arrived within quenching time)
- One pixel logical signal: 0 or 1
- SiPM at whole integrates over all pixels: SiPM response = number of fired pixels
- Dynamic range ~ number of pixels

## <u>Geometry</u>

- $\bullet$  Each pixel has a size 20-30  $\mu$
- 500-4000 pixels/mm<sup>2</sup>

 Macroscopic unit ~ 1-3 mm
 (0.5mm and 5mm units have been also produced recently)







Each pixel works as a Geiger counter with charge  $Q=\Delta VC$ ,  $C\sim 50 \text{fmF}$ ;  $Q\sim 3\times 50 \text{ fmC} = 150 \text{fmC} = 10^6 \text{ e} - \text{comparable to vacuum phototubes}$ ; much higher than avalanche photo-diods.



Gain increases linearly with overvoltage!
(APD has exponentional behaviour)
Optimal overvoltage is compromise with increased crosstalk (resulting in increased noise rate)

## Timing characteristics



Si<sup>\*</sup> Resistor Al - conductor





- Short Geiger discharge development < 500 ps
- Discharge is guenched by current limiting with polysilicon resistor in each pixel I<10µA

 Pixel recovery time ~  $C_{\text{pixel}}R_{\text{pixel}}=100-500$ ns

# Photon Detection Efficiency (PDE)



- Quantum efficiency is high ~ >80% for optical photons like other Si photodetectors
- Geometrical unefficiency is due to restricted sensitive area: eff ~30-50% depending on sensitive are/total area
- Probability to initiate Geiger discharge ~ 60%
- Finite recovery time for pixels ⇒ dead time depends on internal noise rate and photon occupancies

## Spectral behaviour



 Photon absorbtion length in Si (~1µ) depends on wavelength
 The maximum efficiency can be

efficiency can be tuned according to the task changing the width of depletion region (from green to red)

## Dynamic range

### ITEP test procedure

### Distributions for tested SiPMs



- Check the linearity of the SiPM response
- Use light collected from scintillator and study SiPM response vs number of incident MIPs
- Non-linearity at large N because of saturation due to finite number of pixels

## Single pixel dark rate



 Electronic noise is small <10% of a single pixel standard signal -> results only on smearing of the standard signal
 Thermal creation of

 Thermal creation of carriers in the sensitive volume results in standard pulses

Typical one pixel dark rate ~ 1-2 MHz/mm<sup>2</sup> at room temperature

200 Hz/mm<sup>2</sup> at T=100K

## Internal cross-talk

- Single pixel noise rate is huge ⇒ restrict the SiPM application for small light yields (at least at room temperature)
- The probability of N pixel RANDOM noise coincidence within integration time (typically 100 ns) is ~(100)<sup>N</sup> times smaller

• BUT! Cross-talk violates the pixel independence:

- Optical cross-talk: photons created in Geiger discharge (10<sup>-5</sup>/e) can propagate to neighboring pixel
- Electrical pixel-to-pixel decoupling (boundary between pixels and independent quenching resistors) seems to provide electrical pixels independence.
- Cross-talk increases the multypixel firing probabilities

## Internal cross-talk



1p.e. noise rate ~2MHz. threshold 3.5p.e. ~10kHz threshold 6p.e. ~1kHz



## Internal cross-talk



The larger distance between pixel - the smaller cross-talk, but also smaller PDE

## Cross-talk protection



#### Under investigation at ITEP now:

electrons protons neutrons gammas Irradiation with 200 MeV protons IRRA DIATION WITH SR-DO BOURCE BIPM current, JA 08 kRad Dose rate 13.5 Rad/min Irradiation rate 10 Rad/s 7 2.25 2 E 135 ഹ 1.5 SiPM current without Sr90 1.25 з Irradiation rate 0.05 Rad/s 1 2 2.9 kRad 0.7 5 0.5 20 25 30 10 210 8 00 910 Time , hours Protos dose, Rad CURRNOOSENT

Very preliminary

# SiPM's characteristics without irradiation and after 900 rad proton 200 MeV



Very preliminary

### SiPM single pixel spectra and MIP registration without irradiation and after 900 rad proton 200 MeV



- Radiation increases a number of defects around the sensitive area ⇒ The noise rate increases; efficiency becomes smaller due to larger dead time; electronic noise also increased and smear the single pixel signal
- All previous tests on radiation hardness were done with electron or gamma beams.
- Very preliminary conclusion:
  - ~1kRad dose (proton or neutrons) results in ~10 times higher dark current and single pixel noise rate ; PED affected just slightly

Equivalent electron dose is much higher

Please note that we worked with fast irradiation!
 Slow irradiation should be more safe for SiPM

### Scintillator + Wavelength shifter + SiPM



## Scintillator based muon systems



MIP Landau distribution starts above 10 fired pixels! (WLS fiber is not glued to strip)

### 8m<sup>2</sup> ALICE TOF Cosmic Test System is being built at ITEP



- ·dense packing ensures the absence of 'dead' zones
- $\cdot$  intrinsic noise of a single cell ~ 0.01 Hz
- rate capability up to ~ 10KHz/cm<sup>2</sup>
- time resolution ~ 1.2 ns

### CALICE Collaboration: Scintillator tile analog or semidigital HCAL



### TOF with SiPM (MEPhI)

SiPM 3×3 mm<sup>2</sup> attached directly to BICRON - 418 scintillator 3×3×40 mm<sup>3</sup> Signal is readout directly from SiPM w/o preamp and shaper!



## Producers

- In Russia SiPM are produced by three independent (and competing) groups: MEPhI (B.Dolgoshein), CPTA Moscow (V.Golovin) and Dubna (Z.Sadygov)
- Similar performance has been reached.
- No real mass production yet, each of the producers is has built ~10000 pieces so far
- Many R&D for future detectors including LHC and ILC use SiPM from all three producers.
- Now developed at Hamamatsu

## <u>Summary</u>

- Many real advantages of SiPM (in addition to discussed above):
  - Compactness
  - Insensitivity to Magnetic fields
  - Low operating voltage, low power consumption
  - Low charge particle sensitivity
  - Long term stability (but further study required)
- But there are some critical points:
  - Radiation hardness is low
  - Large noise restricts the application with low light yield
  - No real detector based on SiPM built sofar